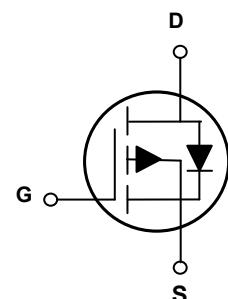
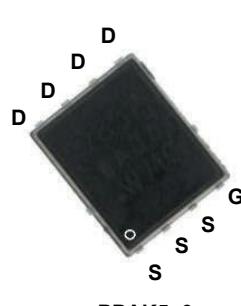


Main Product Characteristics

| | |
|---------------|------------|
| $V_{(BR)DSS}$ | -60V |
| $R_{DS(ON)}$ | 9mΩ (Max.) |
| I_D | -86A |



Features and Benefits

- Advanced MOSFET process technology
- Ideal for high efficiency switched mode power supplies
- Low on-resistance with low gate charge
- Fast switching and reverse body recovery



Description

The GSFP6009 utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supplies and a wide variety of other applications.

Absolute Maximum Ratings ($T_A=25^\circ\text{C}$ unless otherwise specified)

| Parameter | Symbol | Max. | Unit |
|---|-----------------|-------------|------|
| Drain-Source Voltage | V_{DS} | -60 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | V |
| Drain Current-Continuous ($T_C=25^\circ\text{C}$), $V_{GS}=10\text{V}^1$ | I_D | -86 | A |
| Drain Current-Continuous ($T_C=100^\circ\text{C}$), $V_{GS}=10\text{V}^1$ | | -55 | A |
| Drain Current-Pulsed ² | I_{DM} | -344 | A |
| Maximum Power Dissipation ($T_C=25^\circ\text{C}$) ³ | P_D | 130 | W |
| Single Pulse Avalanche Energy ($L=0.3\text{mH}$) | E_{AS} | 812 | mJ |
| Single Pulse Avalanche Current ($L=0.3\text{mH}$) | I_{AS} | 57 | A |
| Junction-to-Ambient ($t \leq 10\text{s}$) ⁴ | $R_{\theta JA}$ | 60 | °C/W |
| Maximum Junction-to-Case | $R_{\theta JC}$ | 0.96 | °C/W |
| Operating Junction Temperature Range | T_J | -55 To +150 | °C |
| Storage Temperature Range | T_{STG} | -55 To +150 | °C |

Electrical Characteristics ($T_A=25^\circ\text{C}$ unless otherwise specified)

| Parameter | Symbol | Conditions | Min. | Typ. | Max. | Unit |
|---|----------------------------|--|------|-------|-----------|------------------|
| On / Off Characteristics | | | | | | |
| Drain-Source Breakdown Voltage | BV_{DSS} | $V_{\text{GS}}=0\text{V}, I_{\text{D}}=-250\mu\text{A}$ | -60 | - | - | V |
| Drain-to-Source Leakage Current | I_{DSS} | $V_{\text{DS}}=-60\text{V}, V_{\text{GS}}=0\text{V}$ | - | - | -1 | μA |
| Drain-to-Source Leakage Current | | $V_{\text{DS}}=-60\text{V}, V_{\text{GS}}=0\text{V}, T_J=125^\circ\text{C}$ | - | - | -50 | μA |
| Gate-to-Source Leakage Current | I_{GSS} | $V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$ | - | - | ± 100 | nA |
| Gate Threshold Voltage | $V_{\text{GS}(\text{th})}$ | $V_{\text{GS}}=V_{\text{DS}}, I_{\text{D}}=-250\mu\text{A}$ | -1.0 | - | -3 | V |
| Drain Static-Source On-Resistance | $R_{\text{DS}(\text{ON})}$ | $V_{\text{GS}}=-10\text{V}, I_{\text{D}}=-20\text{A}$ | - | 7.3 | 9 | $\text{m}\Omega$ |
| | | $V_{\text{GS}}=-4.5\text{V}, I_{\text{D}}=-10\text{A}$ | - | 8.5 | 11 | $\text{m}\Omega$ |
| Dynamic and Switching Characteristics | | | | | | |
| Total Gate Charge | Q_g | $V_{\text{DD}}=-30\text{V}, I_{\text{D}}=-30\text{A}, V_{\text{GS}}=-10\text{V}$ | - | 196 | - | nC |
| Gate-Source Charge | Q_{gs} | | - | 27 | - | |
| Gate-Drain Charge | Q_{gd} | | - | 44 | - | |
| Turn-On Delay Time | $t_{\text{d}(\text{on})}$ | $V_{\text{DD}}=-30\text{V}, R_G=3\Omega, R_L=1.5\Omega, V_{\text{GS}}=-10\text{V}$ | - | 26 | - | nS |
| Rise Time | t_r | | - | 33 | - | |
| Turn-Off Delay Time | $t_{\text{d}(\text{off})}$ | | - | 272 | - | |
| Fall Time | t_f | | - | 91 | - | |
| Input Capacitance | C_{iss} | $V_{\text{DS}}=-30\text{V}, V_{\text{GS}}=0\text{V}, F=1\text{MHz}$ | - | 13300 | - | pF |
| Output Capacitance | C_{oss} | | - | 510 | - | |
| Reverse Transfer Capacitance | C_{rss} | | - | 470 | - | |
| Gate Resistance | R_g | $F=1\text{MHz}$ | - | 1.8 | - | Ω |
| Source-Drain Ratings and Characteristics | | | | | | |
| Maximum Body-Diode Continuous Current | I_s | MOSFET symbol showing the integral reverse p-n junction diode. | - | -86 | - | A |
| Maximum Body-Diode Pulse Current | I_{SM} | | - | -344 | - | A |
| Diode Forward Voltage | V_{SD} | $V_{\text{GS}}=0\text{V}, I_s=-10\text{A}, T_J=25^\circ\text{C}$ | - | -0.9 | -1.2 | V |
| Reverse Recovery Time | T_{rr} | $I_F=-20\text{A}, \frac{di}{dt}=100\text{A}/\mu\text{s}, T_J=25^\circ\text{C}$ | - | 36.4 | - | nS |
| Reverse Recovery Charge | Q_{rr} | | - | 43.1 | - | nC |

Notes:

- Calculated continuous current based on maximum allowable junction temperature.
- Repetitive rating; pulse width limited by max. junction temperature.
- The power dissipation P_D is based on max. junction temperature, using junction-to-case thermal resistance.
- The value of $R_{\theta JA}$ is measured with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$.

Typical Electrical and Thermal Characteristic Curves

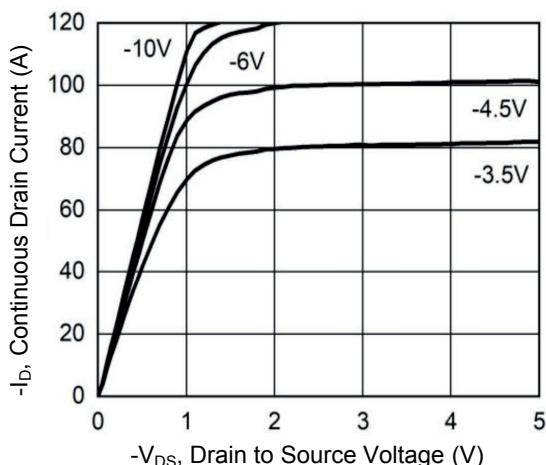


Figure 1. Output Characteristics

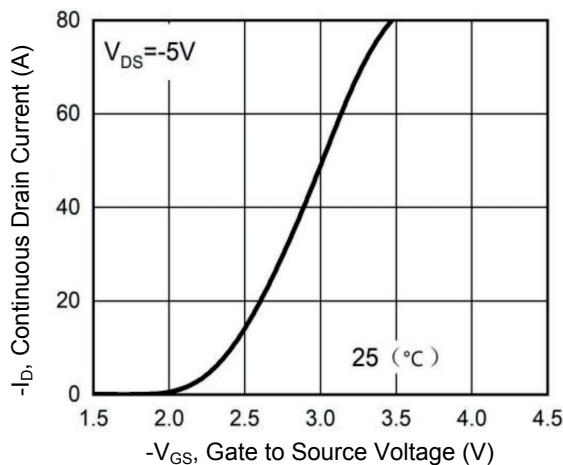


Figure 2. Transfer Characteristics

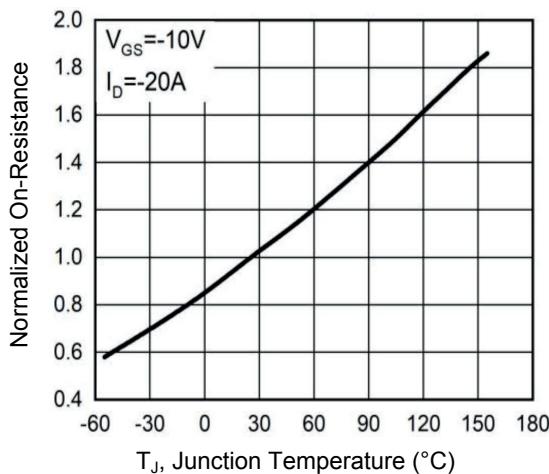


Figure 3. Normalized $R_{DS(\text{ON})}$ vs. T_J

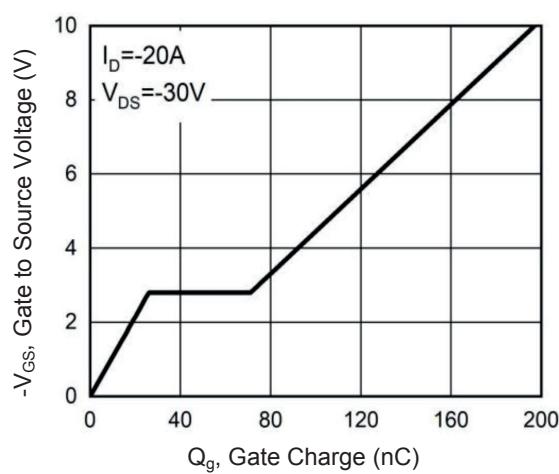


Figure 4. Gate Charge Waveform

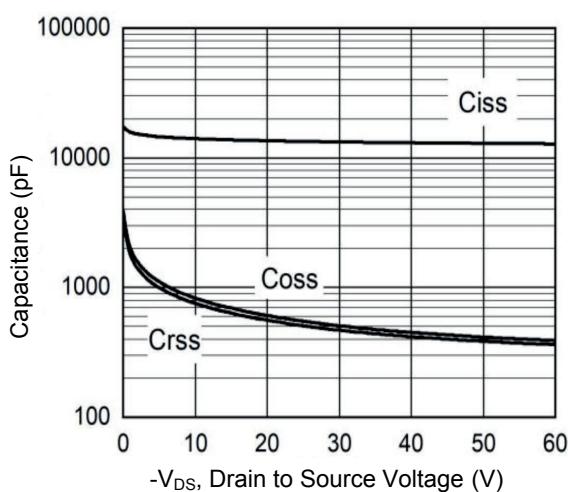


Figure 5. Capacitance Characteristics

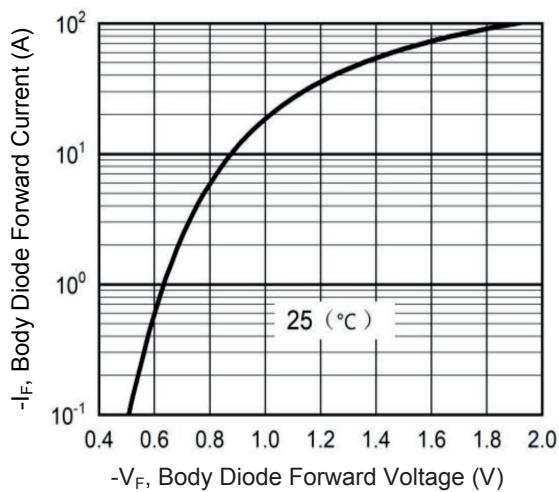
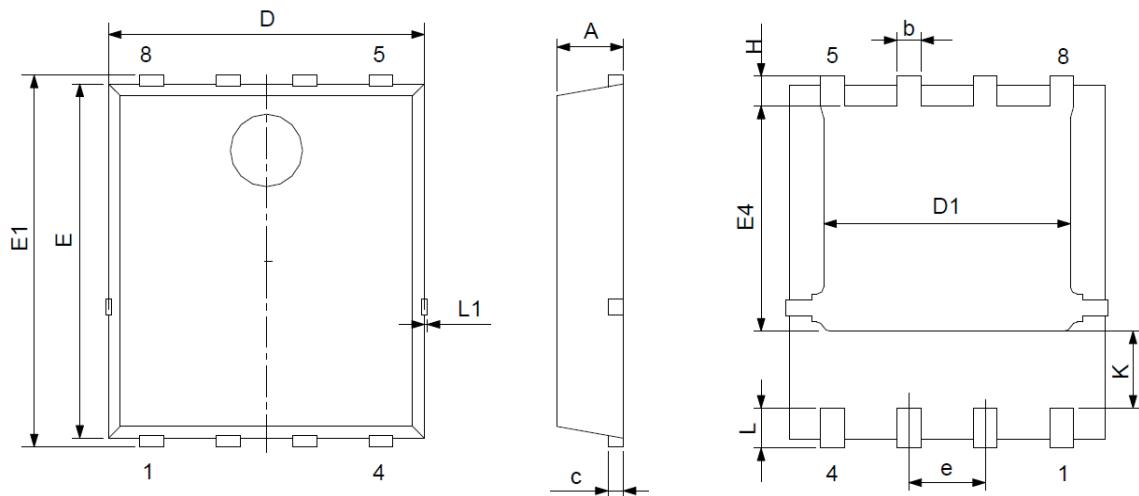


Figure 6. Body Diode Characteristics

Package Outline Dimensions (PPAK5x6)



| Symbol | Dimensions In Millimeters | | Dimensions In Inches | |
|--------|---------------------------|-------|----------------------|-------|
| | Min. | Max. | Min. | Max. |
| A | 0.900 | 1.200 | 0.035 | 0.047 |
| c | 0.154 | 0.354 | 0.006 | 0.014 |
| D | 4.800 | 5.400 | 0.189 | 0.213 |
| E | 5.660 | 6.060 | 0.223 | 0.239 |
| D1 | 3.760 | 4.300 | 0.148 | 0.169 |
| E1 | 5.900 | 6.350 | 0.232 | 0.250 |
| b | 0.300 | 0.550 | 0.012 | 0.022 |
| k | 1.100 | 1.500 | 0.043 | 0.059 |
| e | 1.070 | 1.370 | 0.042 | 0.054 |
| E4 | 3.340 | 3.920 | 0.131 | 0.154 |
| L | 0.300 | 0.710 | 0.012 | 0.028 |
| L1 | - | 0.120 | - | 0.005 |
| H | 0.400 | 0.710 | 0.016 | 0.028 |

Order Information

| Device | Package | Marking | Carrier | Quantity |
|----------|---------|---------|-------------|------------------|
| GSFP6009 | PPAK5x6 | P6009 | Tape & Reel | 5,000 Pcs / Reel |

For more information, please contact us at: inquiry@goodarksemi.com